ABSTRACT

Due to polymorphism and complex crystal structure, compounds of the argyrodite family and phases based on them exhibit several interesting functional properties, such as thermoelectric, photoelectric, optical, as well as ionic conductivity for Cu⁺ and Ag⁺ cations. The paper presents the results of the study of phase equilibria in the Ag₈SiSe₆-Ag₈SiTe₆ system by DTA, XRD, and SEM methods. Refined data on the melting temperature (1278 K) and polymorphic transitions (315 K and 354 K) of the Ag₈SiSe₆ compound are presented. The crystallographic parameters of LT-Ag₈SiSe₆ (Cubic, F-43m, \(a = 1.0965 \text{ nm}\)) and IT-Ag₈SiSe₆ (Cubic, P4_232, \(a = 1.0891 \text{ nm}\)) are also determined. It has been established that the investigated system is quasi-binary and its phase diagram is characterized by the formation of a continuous series of substitutional solid solutions between HT-Ag₈SiSe₆ and Ag₈SiTe₆. This process is accompanied by a strong decrease in the temperatures of polymorphic transformations of Ag₈SiSe₆, which leads to the stabilization of the ion-conducting cubic phase at room temperature in the >10 mol% Ag₈SiTe₆ compositions area. The crystal lattice parameters of the synthesized solid solutions are calculated by indexing the powder diffraction patterns. The stabilization of the high-temperature cubic phase at room temperature achieved by us presents new opportunities for the development of environmentally friendly thermoelectrics and ion-electronic conductors based on silicon argyrodites with desired composition and properties.

Keywords: silver-silicon chalcogenides; argyrodite-like compounds; differential thermal analysis; X-ray diffraction analysis; phase equilibria; solid solutions; polymorphic transformation

1. Introduction

Silver and copper chalcogenides, due to their electronic, optical and mechanical properties, are good environmentally friendly materials for a wide range of applications, for example, as thermoelectric and photovoltaic materials, ionic conductors[11–7]. Recent studies show the promise of using them also in biomedicine[8,9] and for photoelectrochemical water splitting[10–12].

Among these materials, an important place is occupied by compounds with the general formula A⁺B⁴⁺X₆ (A⁺-Cu, Ag; B⁴⁺-Si, Ge, Sn; X-S, Se, Te) that belong to the argyrodite family. These compounds are of particular interest due to their thermoelectric properties[13–20], photosensitivity[21–23], and low-temperature phase transition[6,24]. These materials can be used in the production of hydrogen, as well as in a variety of applications such as ion-selective electrodes, solid-state electrolytes in various types of electric batteries,
electrochemical sensors, and displays\textsuperscript{[25–32]}. According to some papers\textsuperscript{[14,17,31,32]}, the presence of mixed electronic-ionic conductivity is one of the significant factors that positively impact the thermoelectric characteristics of these materials.

A set of reliable data on phase equilibria and thermodynamic data play an important role in choosing the conditions for the directed synthesis of new materials\textsuperscript{[33–35]}. Systems in which solid solutions are formed are of particular interest, since varying the composition can change the properties of the phases\textsuperscript{[36–39]}. The constructed phase diagrams of such systems serve as the basis for choosing the composition of melts for growing single crystals of solid solutions of a given composition by the directed crystallization method.

Previously, the results of studies of systems composed of copper or silver chalcogenides and characterized by the formation of continuous or wide areas of solid solutions were presented\textsuperscript{[40–46]}.

In recent years, silicon-containing argyrodites, especially Ag\textsubscript{8}SiSe\textsubscript{6} and Ag\textsubscript{8}SiTe\textsubscript{6}, have attracted particular interest as eco-friendly thermoelectric and ion-conducting materials\textsuperscript{[16,18,19]}.

In this work, in order to obtain new silicon argyrodites of variable composition, we studied phase equilibria in the Ag\textsubscript{8}SiSe\textsubscript{6}-Ag\textsubscript{8}SiTe\textsubscript{6} system.

The initial compounds of the above-mentioned system have been studied in many works. The Ag\textsubscript{8}SiSe\textsubscript{6} melts congruently. In various papers, very different values of the melting point of this compound are given. Thus, this compound melts at 1203 K\textsuperscript{[24,47]}. In other papers, the following data are given: 1258 K\textsuperscript{[48]}, 1268 K\textsuperscript{[49]}. The phase diagram presented by Jiang et al.\textsuperscript{[16]} does not indicate a certain temperature of the distectics point, but only a possible melting temperature range (1203–1263 K).

The Ag\textsubscript{8}SiSe\textsubscript{6} compound has at least 3 crystalline modifications\textsuperscript{[16,19,24,47]}. The high-temperature (HT) modification, like all other compounds of the argyrodite family, crystallizes in a face-centered cubic structure (Sp.gr. F\textsubscript{4}3m) with complete disordering of the cationic sublattice. According to various authors, HT-Ag\textsubscript{8}SiSe\textsubscript{6} has the following lattice periods: \(a = 1.097\) nm\textsuperscript{[24,47]}, \(a = 1.09413(1)\) nm\textsuperscript{[19]}. The intermediate modification (IT) has a simple-cubic structure (Sp.gr. \(P2\textsubscript{1}3\)) or \(P4\textsubscript{2}32\) with a lattice constant \(a = 1.087\) nm\textsuperscript{[24]}. The IT-Ag\textsubscript{8}SiSe\textsubscript{6} modification is characterized by partial localization of silver ions\textsuperscript{[19]}. Data on the structure of the low-temperature modification (LT-Ag\textsubscript{8}SiSe\textsubscript{6}) are contradictory. LT-Ag\textsubscript{8}SiSe\textsubscript{6} has a tetragonal structure (Sp.gr. I-\(4m2\), \(a = 0.7706\), \(b = 1.10141\) nm\textsuperscript{[24,47]}). However, Jiang et al.\textsuperscript{[16]} noted that the powder diffraction pattern of LT-Ag\textsubscript{8}SiSe\textsubscript{6} is poorly indexed in this structure. They showed that the diffractogram contains two series of reflections, and most of the peaks are indexed in the orthorhombic structure (Sp.gr \(Pmn2_1\)). Weak peaks near 33.5, 34.7 and 37.0 correspond to orthorhombic RT-Ag\textsubscript{2}Se\textsuperscript{[16]}.

The Ag\textsubscript{8}SiTe\textsubscript{6} melts congruently at 1143 K\textsuperscript{[24]} and has two polymorphic transformations at 195 and 263 K\textsuperscript{[50]}. The period of cubic lattice (Sp.gr. F-43m is \(a = 1.15225\) nm\textsuperscript{[50]}).

Based on the literature data, it can be assumed that continuous solid solutions can form between the high-temperature modification of HT-Ag\textsubscript{8}SiSe\textsubscript{6} and Ag\textsubscript{8}SiTe\textsubscript{6}.

2. Materials and methods
For the synthesis of Ag\textsubscript{8}SiSe\textsubscript{6} and Ag\textsubscript{8}SiTe\textsubscript{6} compounds, the high-purity elements (at least 99.999 wt.\% purity) were used. The synthesis was carried out in ampoules evacuated to \(10^{-2}\) Pa. To avoid a reaction between silicon and the walls of the quartz ampoule, the inner walls of the tube were graphitized by pyrolysis of toluene.

Given the high vapor pressure of selenium at the melting point of Ag\textsubscript{8}SiSe\textsubscript{6}\textsuperscript{[51]}, this compound was synthesized in an in inclined two-zone furnace. Stoichiometric amounts of elementary components were loaded into a quartz ampoule (~13–15 cm long and ~1.5 cm in diameter), which, after evacuation and sealing, was placed in an inclined (~30°) tube furnace. Two-thirds of the ampoule was in the furnace, and the rest of
the upper part was outside the furnace. The furnace was heated to 1300 K. At the beginning of the experiment, selenium evaporates and accumulates in the upper “cold” zone of the ampoule, from where it returned to the lower “hot” zone again. To prevent the explosion of the ampoule due to overheating of the “cold” zone, the latter was cooled with water. As the components interacted, the amount of selenium in the upper part of the ampoule decreased, which could be observed visually. After the interaction of a larger mass of components, the ampoule was completely placed in the furnace.

Synthesis of the Ag₈SiTe₆ compound was carried out at 1200 K.

DTA and XRD analysis were used for the identification of the synthesized compounds.

**Figure 1** presents the DTA data of the Ag₈SiSe₆ and Ag₈SiTe₆ compounds. As can be seen, these compounds melt at 1278 K and 1143 K. On the heating thermogram of the Ag₈SiSe₆ compound, there are also endothermic effects at 315 K and 354 K, corresponding to the polymorphic transitions. The data for Ag₈SiTe₆ compounds are in agreement with the literature[24]. According to our experimental data, the melting point of Ag₈SiSe₆ differs significantly from those presented by the authors[24,47,48] and is closer to the data of Piskach et al.[49]. The temperature of the low-temperature phase transition (315 K) coincides with the data of Gorochov[24] and Hofmann[47] while the temperature of the second one (354 K) is slightly lower than given by Studenyak et al.[30].

![Figure 1. Heating DTA curves of the Ag₈SiSe₆ and Ag₈SiTe₆ compounds.](image)

Intermediate samples of the studied system were prepared by melting stoichiometric amounts of pre-synthesized and identified compounds in evacuated quartz ampoules. The alloys were heated to 1300 K and kept at this temperature for about 1 h; then the furnace temperature was reduced to 800 K and the ampoules were kept in it for about 500 h. For some compositions, two series of alloys were prepared: the first series after annealing was quenched in ice water, and the second series of samples was slowly cooled in a furnace to room temperature.

**Figure 2** shows the powder diffraction patterns of the synthesized compounds. The X-ray diffraction pattern of Ag₈SiTe₆ is in agreement with the literature data[24,52]. The diffraction pattern of Ag₈SiSe₆ is almost completely indexed in a simple-cubic lattice with Sp.gr. P4̅₃2. Some non-indexed very weak reflection lines do not apply to Ag₂Se, SiSe₂, and initial elemental components. Taking into account the available literature data[16,19], it can be assumed that the synthesized sample is IT-Ag₈SiSe₆ with an insignificant part of LT-Ag₈SiSe₆. This assumption is supported by the DTA data, according to which the obtained sample has a clear isothermal melting peak, which is possible only if its composition coincides with the stoichiometry of Ag₈SiSe₆.
The obtained alloys were investigated by using DTA, XRD, and SEM methods.

The DTA curves were recorded using a NETZSCH 404 F1 Pegasus system with chromel-alumel thermocouples in the range of temperatures from room temperature to \( \sim 1400 \) K at a heating rate of 10 K-min\(^{-1}\) and standard uncertainty \( \pm 2^\circ \). Temperatures of thermal effects were taken mainly from the heating curves. But in some samples, thermal effects were taken from cooling curves to determine the onset of crystallization. As a reference material, in (429 K), Tl (576 K), Zn (692 K), Sb (904 K), KCl (1043 K), Ag (1236 K), as well as Cu (1358 K) with an accuracy of \( \pm 1^\circ \) were used.

![DTA Curves](image1)

**Figure 2.** Powder diffraction patterns of the synthesized Ag\(_8\)SiSe\(_6\) and Ag\(_8\)SiTe\(_6\) compounds.

X-ray powder diffraction data were collected at room temperature using a Bruker D8 ADVANCE diffractometer (with Cu-K\(\alpha\) radiation) within 2\(\theta = 10^\circ \) to 70\(^\circ \). The unit cell parameters were calculated by indexing powder patterns using Topas V3.0 software.

SEM-EDS analyses were done by Tescan Vega 3 SBH Scanning Electron Microscope equipped with Thermo Scientific Ultra Dry Compact EDS detector.
3. Results and discussion

Analysis of the powder diffraction patterns of both series of synthesized alloys with compositions of 10–90 mol% Ag₈Si₆Te₆ showed that they all have diffraction patterns characteristic for the HT-cubic \( F-43m \) space group. Figure 3 shows powder diffractograms of alloys slowly cooled after annealing. As can be seen, all intermediate alloys have diffraction patterns that are qualitatively different from IT-Ag₈SiSe₆ and are similar to the diffraction pattern of Ag₈SiTe₆. Some shift of the reflection lines with increasing tellurium content towards smaller angles is associated with an increase in the lattice period during the formation of solid solutions.

Table 1 presents the crystallographic data of slowly cooled after annealing and quenched from 800 K both initial compounds and alloys of the Ag₈SiSe₆-Ag₈SiTe₆ system, and Figure 4 shows a graph of the concentration dependence of the cubic lattice period. As can be seen, for both series of alloys, the lattice period is an almost linear function of the composition, i.e., Vegard’s law is obeyed. It should be noted that the values of the lattice constant of cubic phases at room temperature are somewhat smaller than those of alloys quenched from 800 K, which is apparently due to the thermal expansion of the crystal lattice of quenched samples compared to room temperature.

<table>
<thead>
<tr>
<th>Composition, mol% Ag₈Si₆Te₆</th>
<th>Syngony, Sp.gr., lattice parameters, nm</th>
</tr>
</thead>
<tbody>
<tr>
<td>Ag₈Si₆Te₆</td>
<td>Cubic, ( P4\overline{3}2 ), ( a = 1.0891(3) )</td>
</tr>
<tr>
<td>10</td>
<td>Cubic, ( F-43m ), ( a = 1.1018(3) )</td>
</tr>
<tr>
<td>20</td>
<td>( &quot;), ( a = 1.1070(4) )</td>
</tr>
<tr>
<td>40</td>
<td>( &quot;), ( a = 1.1175(3) )</td>
</tr>
<tr>
<td>50</td>
<td>( &quot;), ( a = 1.1230(4) )</td>
</tr>
<tr>
<td>60</td>
<td>( &quot;), ( a = 1.1293(3) )</td>
</tr>
<tr>
<td>80</td>
<td>( &quot;), ( a = 1.1405(4) )</td>
</tr>
<tr>
<td>Ag₈Si₆Se₆</td>
<td>( &quot;), ( a = 1.1524(4) )</td>
</tr>
</tbody>
</table>

Table 1. Crystallographic parameters of phases in the Ag₈SiSe₆-Ag₈SiTe₆ system.
Table 2 presents the DTA data of the heating curves for the alloys slowly cooled after annealing. Figure 5 shows the phase diagram constructed based on these data. As can be seen, the system is quasi-binary and is characterized by the formation of a continuous series of solid solutions (γ-phase) between HT-Ag$_8$SiSe$_6$ and Ag$_8$SiTe$_6$. On the liquidus and solidus curves, the temperature changes monotonically between the melting points of initial compounds, and the melting temperature range does not exceed 15°. On the DTA curves of the alloys, in contrast to pure Ag$_8$SiSe$_6$, we did not detect low-temperature thermal effects reflecting its polymorphic transitions. This, taking into account the XRD data, suggests that the formation of solid solutions is accompanied by a strong decrease in the temperatures of polymorphic transitions of Ag$_8$SiSe$_6$ (315 K and 354 K) and their transition to the temperature range below room temperature in the composition range of 0–10 mol% Ag$_8$SiTe$_6$.

**Table 2.** The DTA results for the alloys of the Ag$_8$SiSe$_6$-Ag$_8$SiTe$_6$ system.

<table>
<thead>
<tr>
<th>Composition, mol% Ag$_8$SiTe$_6$</th>
<th>Thermal effects, K</th>
</tr>
</thead>
<tbody>
<tr>
<td>Pure-Ag$_8$SiSe$_6$</td>
<td>315; 354; 1278</td>
</tr>
<tr>
<td>10</td>
<td>1262</td>
</tr>
<tr>
<td>20</td>
<td>1250–1264</td>
</tr>
<tr>
<td>40</td>
<td>1222–1237</td>
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<tr>
<td>50</td>
<td>1210–1225</td>
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<tr>
<td>60</td>
<td>1198–1212</td>
</tr>
<tr>
<td>80</td>
<td>1168–1278</td>
</tr>
<tr>
<td>90</td>
<td>1158–1165</td>
</tr>
<tr>
<td>Pure-Ag$_8$SiTe$_6$</td>
<td>1143</td>
</tr>
</tbody>
</table>

**Figure 4.** Dependence of the period of the cubic lattice on the composition for solid solutions of the Ag$_8$SiSe$_6$-Ag$_8$SiTe$_6$ system.

**Figure 5.** Phase diagram of the Ag$_8$SiSe$_6$-Ag$_8$SiTe$_6$ system.
The character of solid-phase equilibria in the Ag$_8$SiSe$_6$-Ag$_8$SiTe$_6$ system was also confirmed by the SEM method. It was shown that all synthesized samples are single-phase. Figure 6 presents SEM-EDS data of annealed and slowly cooled alloy with a composition of 20 mol% Ag$_8$SiTe$_6$. As can be seen, this alloy is single-phase and its elemental composition practically coincides with the nominal Ag$_8$SiSe$_{4.8}$Te$_{1.2}$.

Figure 6. SEM-EDS data for the alloy with Ag$_8$SiTe$_{1.2}$Se$_{4.8}$ composition. (A) SEM image; (B) atomic composition of elements.

4. Conclusion

We present new data on phase equilibria in the Ag$_8$SiSe$_6$-Ag$_8$SiTe$_6$ system, obtained by DTA, XRD and SEM are presented. The temperatures of melting and polymorphic transitions, as well as the crystallographic parameters of the HT- and IT- modifications of the Ag$_8$SiSe$_6$ compound, for which contradictory literature data were available, are refined.

We have shown that the Ag$_8$SiSe$_6$-Ag$_8$SiTe$_6$ system is quasi-binary. Its T-x diagram in the high-temperature region is characterized by the formation of continuous solid substitution solutions between HT-Ag$_8$SiSe$_6$ and Ag$_8$SiTe$_6$. The formation of solid solutions is accompanied by a strong decrease in the temperatures of Ag$_8$SiSe$_6$ polymorphic transformations. This leads to the stabilization of the ion-conducting cubic phase with Sp.gr. $Fm-3m$ at room temperature in a wide range of compositions (>10 mol% Ag$_8$SiTe$_6$). According to powder diffraction patterns, the crystal lattice parameters of the synthesized solid solutions were calculated. It is shown that the dependence of the cubic lattice period on the composition obeys Vegard’s rule.

The obtained new data open up wide opportunities for obtaining environmentally friendly thermoelectrics and ion-electronic conductors based on silicon argyrodites with controlled composition and properties.

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Author contributions

Conceptualization, YAY; methodology, AJA and KNB; investigation, AJA and KNB; resources, SZI; data curation, YAY; writing—original draft preparation, AJA; writing—review & editing, KNB; visualization, SZI; project administration, MBB; funding acquisition, MBB.

Conflict of interest

The authors declare no conflict of interest.
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